Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,508	HAN ET AL.	
Examiner	Art Unit	
Yong Chu	1626	

SEARCHED			
Class	Subclass	Date	Examiner
548	186	4/4/2006	YC
514	369	4/4/2006	YC
548	253	4/4/2006	YC
514	382	4/4/2006	YC

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SI (INCLUDIN	EARCH NOTES G SEARCH STRATEGY	")
	DATE	EXMR
STN	4/3/2006	YC
EAST	4/4/2006	YC
PALM	4/4/2006	YC